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April 2015

FDB390N15A

N-Channel PowerTrench[®] MOSFET 150 V, 27 A, 39 m Ω

Features

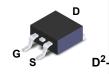
- $R_{DS(on)}$ = 33.5 m Ω (Typ.) @ V_{GS} = 10 V, I_D = 27 A
- · Fast Switching Speed
- Low Gate Charge, Q_G = 14.3 nC (Typ.)
- High Performance Trench Technology for Extremely Low $R_{DS(on)}$
- · High Power and Current Handling Capability
- RoHS Compliant

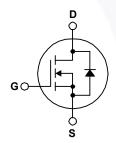
Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench[®] process that has been tailored to minimize the on-state resistance while maintaining superior switching performance.

Applications

- · Consumer Appliances
- · LED TV
- · Synchronous Rectification
- · Uninterruptible Power Supply
- · Micro Solar Inverter





Absolute Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol		Parameter	FDB390N15A	Unit	
V _{DSS}	Drain to Source Voltage		150	V	
V	Cata to Course Valtage	- DC	±20	V	
V_{GSS}	Gate to Source Voltage	- AC (f > 1 Hz)	±30	V	
I _D	Drain Current	- Continuous (T _C = 25°C,Silicon Limited)	27	A	
	Drain Current	- Continuous (T _C = 100°C,Silicon Limited)	19		
I _{DM}	Drain Current	- Pulsed (Note 1)	108	Α	
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	78	mJ	
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	6.0	V/ns	
D	Daniel Bianie attan	$(T_C = 25^{\circ}C)$	75	W	
P_{D}	Power Dissipation	- Derate Above 25°C	0.5	W/°C	
T _J , T _{STG}	Operating and Storage Temperat	ure Range	-55 to +175	οС	
T _L	Maximum Lead Temperature for	Soldering, 1/8" from Case for 5 Seconds.	300	οС	

Thermal Characteristics

Symbol	Parameter FDB390N15		Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	2.0	
Б	Thermal Resistance, Junction to Ambient (Minimum Pad of 2-oz Copper), Max.	62.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (1 in ² Pad of 2-oz Copper), Max.	40	

Package Marking and Ordering Information

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FDB390N15A	FDB390N15A	D ² -PAK	Tape and Reel	330 mm	24 mm	800 units

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Charac	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	150	-	-	V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = 250 μA, Referenced to 25°C	-	0.1	-	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 120 V, V _{GS} = 0 V	-	-	1	
		$V_{DS} = 120 \text{ V}, T_{C} = 150^{\circ}\text{C}$	-	-	500	μA
I _{GSS}	Gate to Body Leakage Current	V _{GS} = ±20 V, V _{DS} = 0 V	-	-	±100	nA

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2.0	-	4.0	V
R _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 27 A	-	33.5	39.0	mΩ
9 _{FS}	Forward Transconductance	V _{DS} = 10 V, I _D = 27 A	-	33	-	S

Dynamic Characteristics

C _{iss}	Input Capacitance	V - 75 V V - 0 V	-	965	1285	pF
C _{oss}	Output Capacitance	$V_{DS} = 75 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1 MHz	-	96	130	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 101112	-\	5.8	-	pF
C _{oss(er)}	Energy Related Output Capacitance	V _{DS} = 75 V, I _D = 27 A		169	-	pF
Q _{g(tot)}	Total Gate Charge at 10V		-	14.3	18.6	nC
Q_{gs}	Gate to Source Gate Charge	V _{DS} = 75 V, I _D = 27 A,		5.0	-	nC
Q _{gs2}	Gate Charge Threshold to Plateau	V _{GS} = 10 V	-	2.0	-	nC
Q_{gd}	Gate to Drain "Miller" Charge	(Note 4)	-	3.5	-	nC
ESR	Equivalent Series Resistance (G-S)	f = 1 MHz	-	1.4	-	Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time		-	14	38	ns
t _r		$V_{DD} = 75 \text{ V}, I_{D} = 27 \text{ A},$	-	10	30	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_G = 4.7 \Omega$	-	20	50	ns
t _f	Turn-Off Fall Time	(Note 4)	-	5	20	ns

Drain-Source Diode Characteristics

I _S	Maximum Continuous Drain to Source Diode Forward Current		-	-	27	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current			-	108	Α
V_{SD}	Drain to Source Diode Forward Voltage V _{GS} = 0 V, I _{SD} = 27 A		-	- ,,,/	1.25	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_{SD} = 27 \text{ A}, V_{DD} = 75 \text{ V},$ $dI_{F}/dt = 100 \text{ A}/\mu\text{s}$	-	63	-	ns
Q _{rr}	Reverse Recovery Charge	dI _F /dt = 100 A/μs	-	131	-	nC

Notes

- ${\it 1. Repetitive\ rating: pulse-width\ limited\ by\ maximum\ junction\ temperature.}$
- 2. Starting T_J = 25°C, L = 3 mH, I_{SD} = 7.2 A.
- 3. I $_{SD} \le 27$ A, di/dt ≤ 200 A/µs, V $_{DD} \le BV _{DSS},$ starting T $_{J}$ = 25°C.
- 4. Essentially independent of operating temperature typical characteristics.

Typical Performance Characteristics

Figure 1. On-Region Characteristics

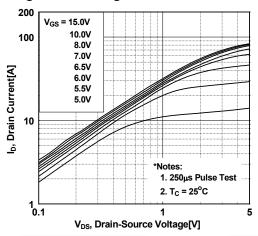


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

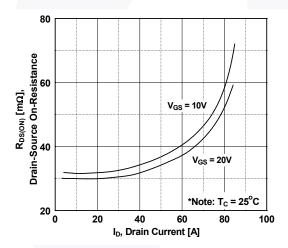


Figure 5. Capacitance Characteristics

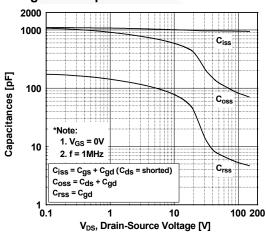


Figure 2. Transfer Characteristics

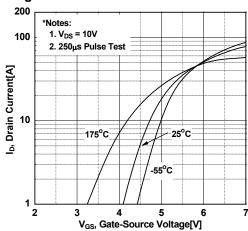


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

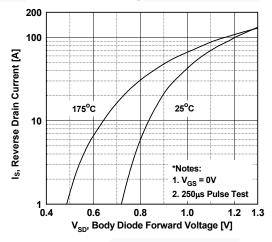
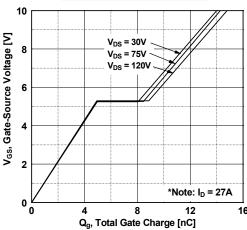


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

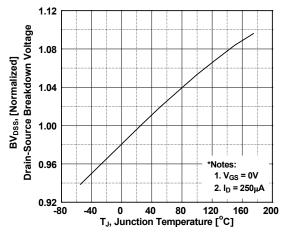


Figure 9. Maximum Safe Operating Area

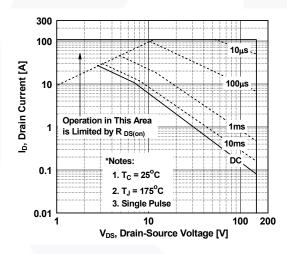


Figure 11. Eoss vs. Drain to Source Voltage

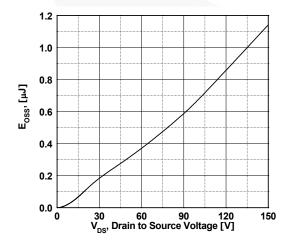


Figure 8. On-Resistance Variation vs. Temperature

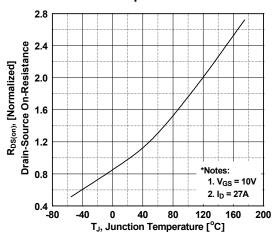


Figure 10. Maximum Drain Current vs. Case Temperature

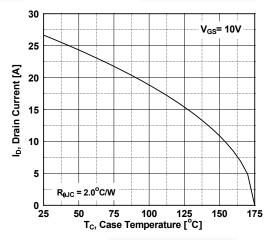
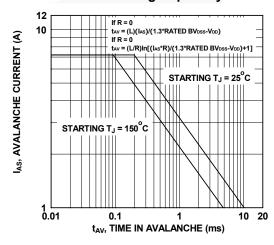
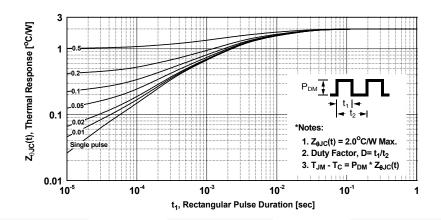


Figure 12. Unclamped Inductive Switching Capability



Typical Performance Characteristics (Continued)

Figure 13. Transient Thermal Response Curve



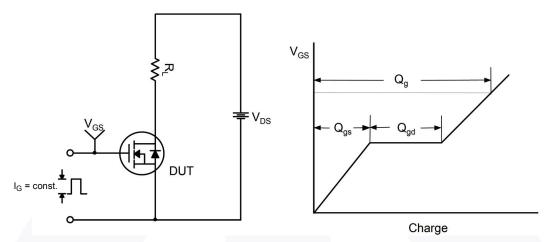


Figure 14. Gate Charge Test Circuit & Waveform

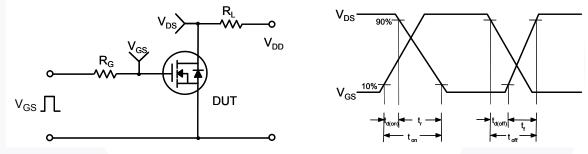


Figure 15. Resistive Switching Test Circuit & Waveforms

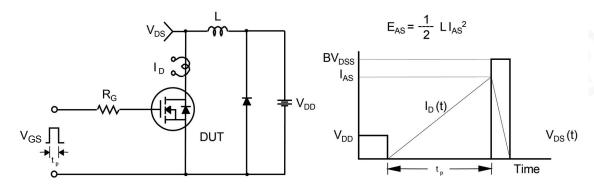


Figure 16. Unclamped Inductive Switching Test Circuit & Waveforms

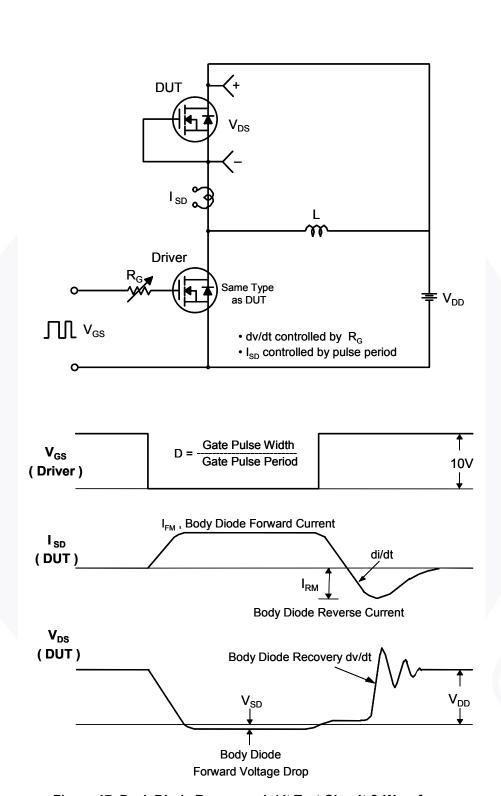
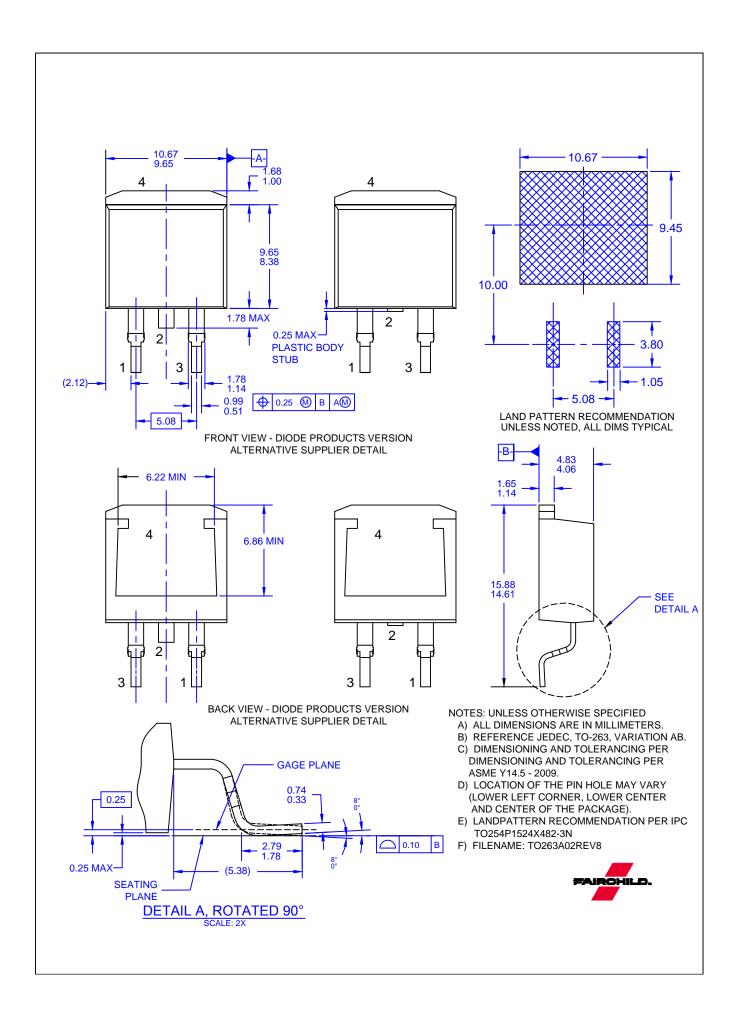


Figure 17. Peak Diode Recovery dv/dt Test Circuit & Waveforms



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